

Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/630,454	LIAW ET AL.
Examiner	Art Unit	
S. Devi, Ph.D.	1645	

## **ISSUE CLASSIFICATION**

ORIGINAL					CROSS REFERENCE(S)									
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
435		252.32			435	843	71.1	170						
INTERNATIONAL CLASSIFICATION														
C	1	2	N	1/20										
C	1	2	N	1/00										
C	1	2	P	1/04										
C	1	2	P	21/04										
				/										
(Assistant Examiner) (Date)					 <b>S. DEVI, PH.D.</b> <b>PRIMARY EXAMINER</b> (Primary Examiner)								Total Claims Allowed: 6	
 <b>W. Phillips</b> 4-19-05 (Legal Instruments Examiner) (Date)					 A.P. 05 (Date)								O.G. Print Claim(s)	O.G. Print Fig.
													1	0